

<b>Notice of References Cited</b>	Application/Control No. 09/986,896	Applicant(s)/Patent Under Reexamination IKEDA ET AL.	
	Examiner Lin Ye	Art Unit 2615	Page 1 of 1

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*	B	US-6,081,015	06-2000	Kamimura, Shinya	257/360
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	M	US-			

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**NON-PATENT DOCUMENTS**

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